

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10020030	MYERS, STEVEN DUANE
	Examiner	Art Unit
	Nguyen-Ba, Hoang-Vu A	2623

SEARCHED

Class	Subclass	Date	Examiner
725	105, 62, 63, 65, 73, 123	9/16/08	HAN
370	311, 320, 487	9/16/08	HAN

SEARCH NOTES

Search Notes	Date	Examiner
East Search -- USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	3/15/07	HAN
Inventor Search -- no DP	9/16/08	HAN
Interference Search -- US-PGPUB -- see search history	9/16/08	HAN
East text search -- USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	9/16/08	HAN
725/105, 62, 63, 73, 65, 123, 74-85; 370/487, 311, 320, 463, 352, 382, 389; 455/12.1, 13.2; 709/231, 232 -- text search	9/16/08	HAN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
725	62, 63, 65, 73, 105, 123	9/16/08	HAN
370	311, 320, 487	9/16/08	HAN

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